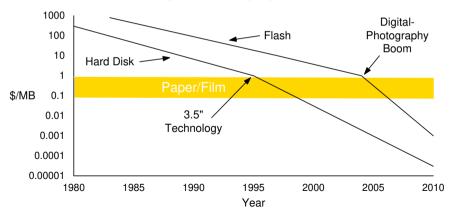
CS 137: File Systems Persistent Solid-State Storage

Technology Change is Coming

- Disks are cheaper than any solid-state memory
- Likely to be true for many years
- But SSDs are now cheap enough for some purposes



ROM

- ROM (Read-Only Memory) chips were programmed in the factory
 - Array of transistors
 - Trivial to leave out a wire to make one "defective"
 - Result was array of ones and zeros
- Most of chip predesigned; only one mask layer changed
- Still fairly expensive for that mask
- Ultra-low cost in large volumes

PROM

PROM (Programmable ROM) is field-programmable

- Array of fuses (literally!)
- Blow a fuse to generate a zero
- Special high-voltage circuitry to select fuse
- Much more expensive per chip than ROM
- But low startup cost made cheaper in low volumes
- One-time use meant lots of chips thrown away

EPROM

- EPROM (Erasable PROM) used floating-gate technology
 - Direct predecessor to flash
 - Electrons in floating gate (see later slide) store data
 - UV light used to drive out electrons and erase
- 15 minutes to erase
- Expensive, but reusability reduced effective cost

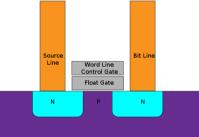




- EEPROM (Electrically Erasable PROM) used thinner oxide layer
- Introduced ca. 1983
- High voltage could erase without UV
- Basically flash memory where entire chip erased at once

Flash Cells

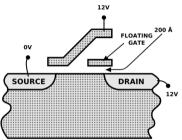
The Flash Cell



- Source line provides voltage, bit line senses
- Current flows between "N" regions, through "P"
- Voltage on control gate restricts current flow in "P"
- Charge on floating gate "screens" control gate
 - Allows sensing whether charge is present

Flash Cells

Programming NOR Flash

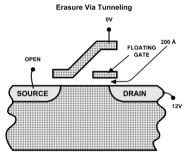


Programming Via Hot Electron Injection

- Default state is 1 (current can flow)
- Apply high voltage to control gate
- Run current through channel
- "Hot" electrons jump through insulation to floating gate

Flash Cells

Erasing NOR Flash



- Apply reverse voltage to control gate
- Disconnect source
- Electrons will now tunnel off floating gate into drain

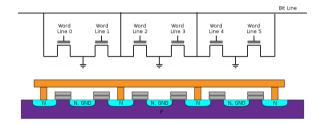


- Some electrons get stuck in oxide during programming
- Add to electric field from floating gate (even if no charge present)
- Eventually becomes impossible to erase effectively

Multilevel Cells (MLC)

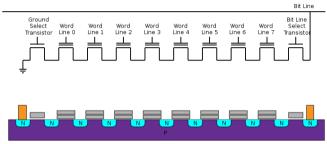
- Classic flash stores charge or not: zero or one
- Possible to store different charge quantities
 - Sense varying current levels
 - Can translate back into multiple bits
 - Current limit is eight levels \equiv three bits
- Obvious density improvement
- Slower to read and write
- Poorer reliability
- Modern chips often combine single-level cells (SLC) for speed with MLC for density

NOR Flash



- All bit lines tied together
- Readout voltage placed on exactly one word line
- If "0" stored, nobody conducts
- If "1" stored, bit line is shorted to ground
 - Works like NOR of word lines

NAND Flash



- Extra-high voltage placed on all but one word line
 - All will conduct
- Remaining line gets "just barely" voltage
 - If programmed, will conduct
- Lower number of bit & ground lines means better density
- Programming via tunnel injection, erase via tunnel release

Comparison of NOR and NAND

NOR flash:

- Lower density
- Usually wired for true random read access
- Wired to allow writing of individual cells
- Erase in blocks of 64-256 KB

NAND flash:

- Cells take about 60% of NOR space
- More space saved by block-read wiring
- Writing ("programming") is in page-sized chunks of 0.5-4 KB
- Erase in blocks of 16-512 kB
- Extra bits (more individually accessible) to provide ECC and per-page metadata
- OK to have bad blocks

A Sample NAND Chip

Samsung K9F8G08U0M (1G×8)

- Each page is 4K bytes + 128 extra
- One block is 64 pages
- Entire device is 8448 Mbits
- 5-cycle access: CAS1, CAS2, RAS1, RAS2, RAS3
 - Eight address bits per cycle
 - CAS is 13 bits + 3 for future
 - RAS is 18 + 6 for future
 - Spare bits mean can later put bigger device into same circuit design
- > On RAS3, loads 4K + 128 into Page Register

Chip Commands

Samsung K9F8G08U0M accepts 16-bit commands, such as:

- Reset
- Read
- Block Erase
- Page Program
- Read Status
- Read for Copy Back
- Copy-Back Program

"Two-plane" commands available for overlapped speedup

Random programming prohibited-but can go back and change metadata

Chip Timing

For Samsung K9F8G08U0M:

- Block erase: 2ms (probably not accurate to µs level)
- Program: 700µs
- Read page to buffer: 25µs
- Read bytes: 25ns per byte

Bottom line:

- ► 25μ s + 4096 × .025 = 25 + 102.4 = 127.4 μ s to read a page
 - = 32.15 MB/s data rate
- > 102.4μ s + $700 = 802.4\mu$ s to write page if already erased
 - Otherwise extra 31.25µs (amortized) to erase
 - Writing is $\approx 6.3 6.5 \times$ slower than reading

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BUT 2ms latency if nothing currently erased.

Comparison to Disk Timing

For 3-TB Seagate Barracuda XT (3.5-inch):

- Average latency: 4.16 ms (7200 RPM)
- Average seek time: 8.5 ms (read), 9.5 ms (write)
- \Rightarrow 12.66 ms to read one random page
- Sustained transfer rate: 149 MB/s = 27.5μ s per 4K bytes

Bottom line: 12.66 ms to read one random page (ouch!)

- 99.4× slower!
- But sequential reads 4.66× faster than flash chip
- Sequential writes are $\approx 30 \times$ faster

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- But sequential reads 4.66× faster than flash chip
- Sequential writes are pprox 30imes faster
- But can wire flash chips in parallel to increase bandwidth

Issues in Using Flash for Storage

- Pre-erasing blocks
- Wear leveling
- Clustering blocks for group writing
- Efficient updates
- ECC and bad-block mapping

Issues in Simulating a Disk

- Can't tell what pages are live
- Expected to allow random updates
- Some blocks (e.g., FAT, inode table) much hotter than others

General Solution: Flash Translation Layer

- All flash "drives" have embedded µprocessor (usually 8051 series)
- Give block-numbered interface to outside world
- Hold back some memory (e.g., 5GB drive pretends to be 4GB)
- Map externally visible blocks to internal physical ones
- Use metadata to track what's live, bad, etc.

Problems in FTLs

- Wear leveling (what if most blocks are read-only?)
 - Solution: must sometimes move RO data
- File system wants to rewrite randomly
 - Solution: group newly written blocks together regardless of logical address
 - Called "Log-Structured File System" (LFS)
 - (We'll read that paper later...)
- Unused block might or might not be live
 - Solution: only reclaim block when overwritten
 - Solution: know that it's FAT and reverse-engineer data as it's written

A Better Way

- Pretending to be a disk is just plain dumb
- When disks came out, we didn't make them look like punched cards
 - ▶ Well...mostly
- If filesystem designed for flash, don't need FTL
 - Problem: need entirely new interface
 - Apple has done it in MacBook Air (advantage of making both hardware and software)
 - Now standardized as Open-Channel
 - Supported in Linux 4.x+ kernels
- Some filesystems designed just for flash: YAFFS, JFFS2, TrueFFS, etc.

The Bad News

- Feature-size limit is around 20 nm
- We're hitting that just about now!
- Some density improvement from MLC and 3-D stacking
- This limit might kill flash as a disk replacement

Other Options

Flash isn't the only choice:

- Phase-change memory (PRAM or PCRAM)—now available from Intel?
- Magnetic RAM (MRAM)

> ???

New technologies offer:

- Read/write times slightly slower than DRAM
- Slower (or no) wear-out
- Longer storage life without refresh
- Byte addressability
 - What happens when filesystems are just like memory?
 - Active current research area